

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NO ET AL.	
		Examiner Joseph L. Perrin, Ph.D.	Art Unit 1746	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0154351	08-2004	Kim et al.	068/012.06
*	B	US-2004/0025545	02-2004	Chang, Jae Won	68/23.1
*	C	US-2003/0160141	08-2003	Yamanashi, Satoru	248/300
*	D	US-6,422,047	07-2002	Magilton, Thomas C.	68/12.06
*	E	US-6,292,966	09-2001	Lim et al.	68/12.06
*	F	US-5,850,746	12-1998	Lee, Dong Geun	68/12.06
*	G	US-5,685,038	11-1997	Smith et al.	68/12.06
*	H	US-4,884,845	12-1989	Schmale et al.	297/367
*	I	US-4,098,098	07-1978	Altnau, Ronald L.	68/23R
*	J	US-3,803,881	04-1974	Getz et al.	68/12.06
*	K	US-3,504,777	04-1970	WAUGH RICHARD A	192/136
*	L	US-3,227,835	01-1966	CONRATH RICHARD L	200/61.45R
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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